

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/041,581	ERIKSSON, ANN-CHRIST	INE	
Examiner	Art Unit		
Brian D. Nguyen	2661		

SEARCHED						
Class	Subclass	Date	Examiner			
370	235 236 229 230.1 230.1 352 329 395.41 395.43	·	BA			

INTERFERENCE SEARCHED						
Class	Subclass	Date	Examiner			
			,			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East	2/2/06 2/3/06	ハン		